

Test Setup photos for RM-429 HAC RF Emissions Test Report

Test report no.:	Salo_HAC_0825_15	Date of report:	2008-06-25
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Measurements made by:	Ari Orte		
Tested devices:	RM-429		
FCC ID:	QMNRM-429	IC:	661X-RM429
Supplement reports:	Salo_HAC_0825_14		
Testing has been carried out in accordance with:	ANSI C63.19-2007 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids		
Documentation:	The documentation of the testing performed on the tested devices is archived for 15 years at TCC Nokia.		
Test results:	The tested device complies with the requirements in respect of all parameters subject to the test. The test results and statements relate only to the items tested. The test report shall not be reproduced except in full, without written approval of the laboratory.		

Date and signatures:

For the contents:

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1. SUMMARY OF HAC RF EMISSION TEST REPORT

1.1 Test Details

Period of test	2008-06-19 to 2008-06-23
SN, HW, SW and DUT numbers of tested device	SN: 004401/10/063985/1, HW: 0110, SW: 3.46, DUT: 25423
Batteries used in testing	BL-5C, DUT: 11546
State of sample	Prototype
Notes	AWF = -5 for GSM

1.2 Picture of Device



Flip closed



Flip open

1.3 Test Positions

1.3.1 Scan area centered at the acoustic output

The device was positioned such that Device Reference plane was touching the bottom of the Test Arch. The scan is centered at the acoustic output by aligning the acoustic output with the intersection of the Test Arch's middle bar and dielectric wire.



Photo of the device positioned under Test Arch